

# BFU668F

NPN wideband silicon RF transistor

Rev. 3 — 24 January 2012

Product data sheet

## 1. Product profile

### 1.1 General description

NPN silicon microwave transistor in a plastic, 4-pin dual-emitter SOT343F package offering an innovative Ku-band DRO solution.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

### 1.2 Features and benefits

- DROs with good output power and low phase noise at very low current consumption: 5 dBm and  $-55$  dBc/Hz/1 kHz at 12 mA
- Low-noise, high gain for low cost LNA solutions
- 40 GHz  $f_T$  silicon technology

### 1.3 Applications

- Ku-band DROs in Ku-band LNBs
- C-band, low current LNAs



## 1.4 Quick reference data

**Table 1. Quick reference data**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
$V_{CBO}$	collector-base voltage	open emitter	-	-	16	V	
$V_{CEO}$	collector-emitter voltage	open base	-	-	5.5	V	
$V_{EBO}$	emitter-base voltage	open collector	-	-	2.5	V	
$I_C$	collector current		-	15	40	mA	
$P_{tot}$	total power dissipation	$T_{sp} \leq 90^\circ\text{C}$	[1]	-	200	mW	
$h_{FE}$	DC current gain	$I_C = 10 \text{ mA}; V_{CE} = 3.5 \text{ V}; T_j = 25^\circ\text{C}$	90	135	200		
$C_{CBS}$	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	138	-	fF	
$f_T$	transition frequency	$I_C = 15 \text{ mA}; V_{CE} = 3.5 \text{ V}; f = 2 \text{ GHz}; T_{amb} = 25^\circ\text{C}$	-	20	-	GHz	
$IP3_{o(max)}$	maximum output third-order intercept point	$I_C = 15 \text{ mA}; V_{CE} = 3.5 \text{ V}; f = 10 \text{ GHz}; T_{amb} = 25^\circ\text{C}; Z_S = Z_L = 50 \Omega$	-	24	-	dBm	
$G_{p(max)}$	maximum power gain	$I_C = 15 \text{ mA}; V_{CE} = 3.5 \text{ V}; f = 10.0 \text{ GHz}; T_{amb} = 25^\circ\text{C}$	[2]	-	10.5	-	dB
NF	noise figure	$I_C = 15 \text{ mA}; V_{CE} = 3.5 \text{ V}; f = 10.0 \text{ GHz}; \Gamma_S = \Gamma_{opt}; T_{amb} = 25^\circ\text{C}$	-	1.7	-	dB	
$P_{L(1dB)}$	output power at 1 dB gain compression	$I_C = 15 \text{ mA}; V_{CE} = 3.5 \text{ V}; Z_S = Z_L = 50 \Omega; f = 10 \text{ GHz}; T_{amb} = 25^\circ\text{C}$	-	12	-	dBm	

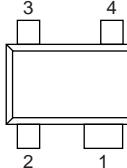
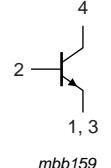
[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

[2]  $G_{p(max)}$  is the maximum power gain, if  $K > 1$ . If  $K < 1$  then  $G_{p(max)} = MSG$ .

## 2. Pinning information

**Table 2. Discrete pinning**

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base		
3	emitter		
4	collector		

mbb159

### 3. Ordering information

**Table 3. Ordering information**

Type number	Package			Version
	Name	Description		
BFU668F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads		SOT343F

### 4. Marking

**Table 4. Marking**

Type number	Marking	Description
BFU668F	ZA*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

### 5. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	16	V
$V_{CEO}$	collector-emitter voltage	open base	-	5.5	V
$V_{EBO}$	emitter-base voltage	open collector	-	2.5	V
$I_C$	collector current		-	40	mA
$P_{tot}$	total power dissipation	$T_{sp} \leq 90^\circ\text{C}$	[1]	200	mW
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	150	°C

[1]  $T_{sp}$  is the temperature at the solder point of the emitter lead.

### 6. Thermal characteristics

**Table 6. Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		270	K/W

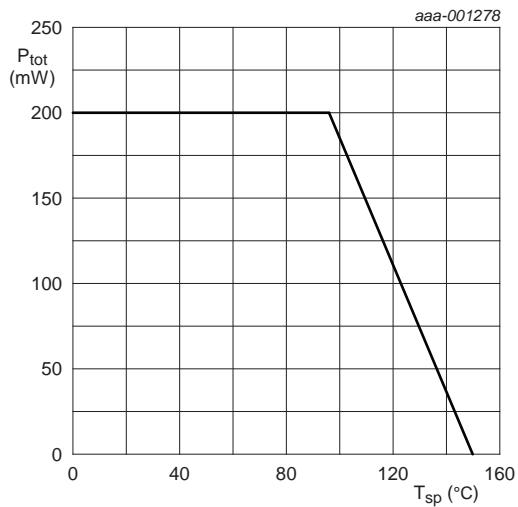


Fig 1. Power derating curve

## 7. Characteristics

**Table 7. Characteristics** $T_j = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(\text{BR})\text{CBO}}$	collector-base breakdown voltage	$I_C = 2.5 \mu\text{A}; I_E = 0 \text{ mA}$	16	-	-	V
$V_{(\text{BR})\text{CEO}}$	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}; I_B = 0 \text{ mA}$	5.5	-	-	V
$I_C$	collector current		-	15	40	mA
$I_{\text{CBO}}$	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{\text{CB}} = 8 \text{ V}$	-	-	100	nA
$h_{\text{FE}}$	DC current gain	$I_C = 10 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}$	90	135	200	
$C_{\text{CES}}$	collector-emitter capacitance	$V_{\text{CB}} = 2 \text{ V}; f = 1 \text{ MHz}$	-	297	-	fF
$C_{\text{EBS}}$	emitter-base capacitance	$V_{\text{EB}} = 0.5 \text{ V}; f = 1 \text{ MHz}$	-	664	-	fF
$C_{\text{CBS}}$	collector-base capacitance	$V_{\text{CB}} = 2 \text{ V}; f = 1 \text{ MHz}$	-	138	-	fF
$f_T$	transition frequency	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; f = 2 \text{ GHz}; T_{\text{amb}} = 25^\circ\text{C}$	-	20	-	GHz
$G_{\text{p(max)}}$	maximum power gain	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; T_{\text{amb}} = 25^\circ\text{C}$ [1]				
		$f = 5.8 \text{ GHz}$	-	14.5	-	dB
		$f = 10.0 \text{ GHz}$	-	10.5	-	dB
$ S_{21} ^2$	insertion power gain	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; T_{\text{amb}} = 25^\circ\text{C}$				
		$f = 5.8 \text{ GHz}$	-	9.5	-	dB
		$f = 10.0 \text{ GHz}$	-	5.0	-	dB
NF	noise figure	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; \Gamma_S = \Gamma_{\text{opt}}; T_{\text{amb}} = 25^\circ\text{C}$				
		$f = 5.8 \text{ GHz}$	-	1.3	-	dB
		$f = 10.0 \text{ GHz}$	-	1.7	-	dB
$G_{\text{ass}}$	associated gain	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; \Gamma_S = \Gamma_{\text{opt}}; T_{\text{amb}} = 25^\circ\text{C}$				
		$f = 5.8 \text{ GHz}$	-	13	-	dB
		$f = 10.0 \text{ GHz}$	-	9.5	-	dB
$P_{L(1\text{dB})}$	output power at 1 dB gain compression	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; Z_S = Z_L = 50 \Omega; T_{\text{amb}} = 25^\circ\text{C}$				
		$f = 5.8 \text{ GHz}$	-	13	-	dBm
		$f = 10.0 \text{ GHz}$	-	12	-	dBm
$\text{IP3}_{\text{o(max)}}$	maximum output third-order intercept point	$I_C = 15 \text{ mA}; V_{\text{CE}} = 3.5 \text{ V}; Z_S = Z_L = 50 \Omega; T_{\text{amb}} = 25^\circ\text{C}$				
		$f = 5.8 \text{ GHz}$	-	24	-	dBm
		$f = 10.0 \text{ GHz}$	-	24	-	dBm

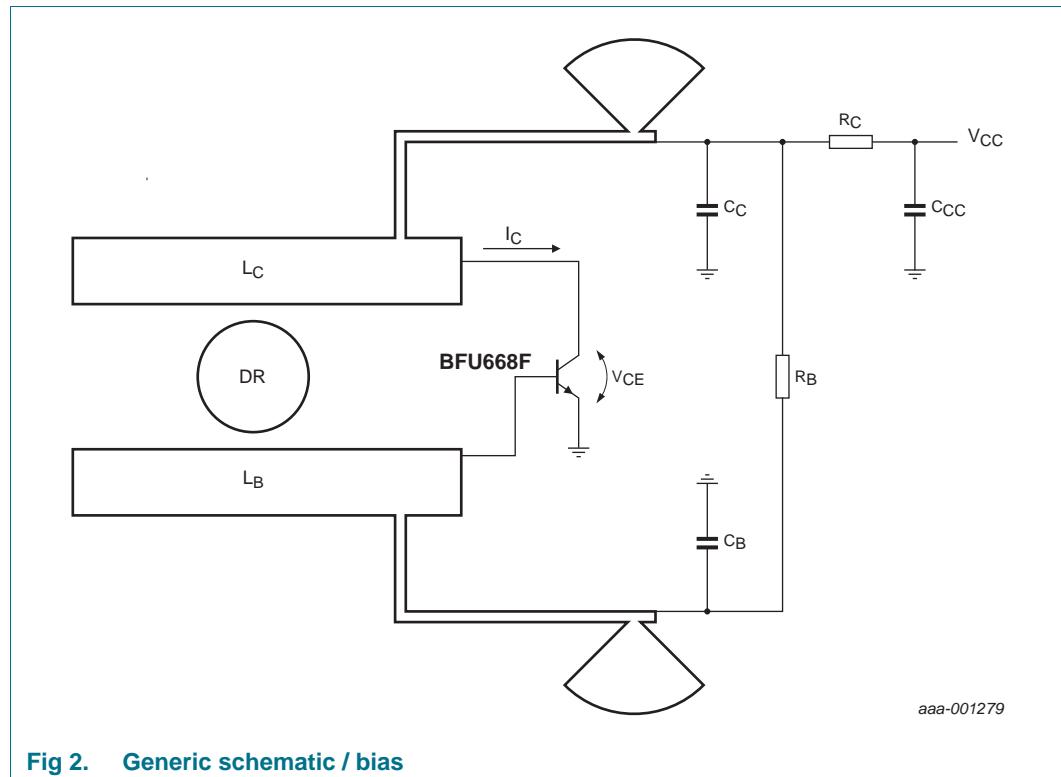
[1]  $G_{\text{p(max)}}$  is the maximum power gain, if  $K > 1$ . If  $K < 1$  then  $G_{\text{p(max)}} = \text{MSG}$ .

## 8. Application information

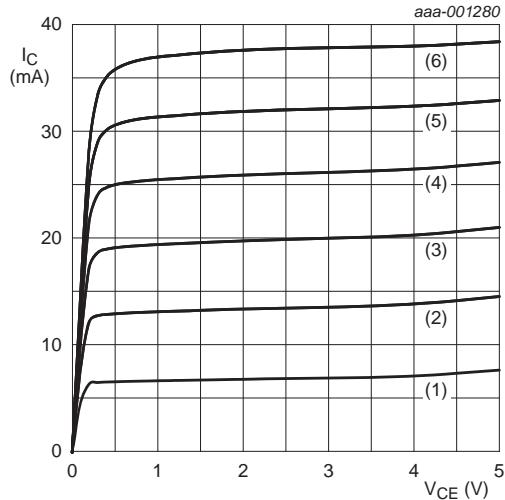
### 8.1 BFU668F Ku-band Dielectric Resonator Oscillator (DRO)

Figure 2 shows a typical DRO circuit using BFU668F as active device. The schematic highlights the bias elements. Evaluation tests, done by replacing the existing transistor with BFU668F, on three different DRO LNBs / configurations, have proven:

- BFU668F achieves similar Phase Noise and RF power as the replaced transistor
- BFU668F achieves same RF performances at approximately half of the bias current

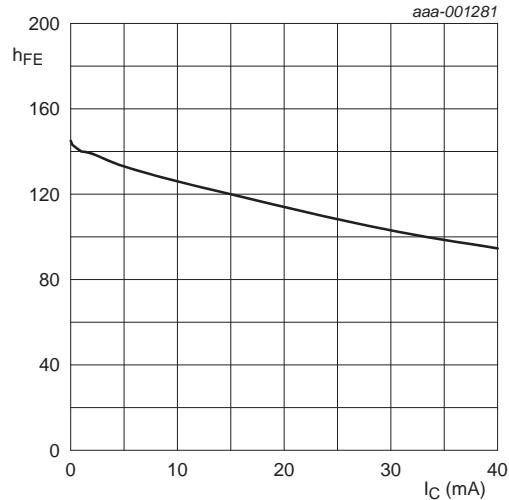


## 8.2 Graphs



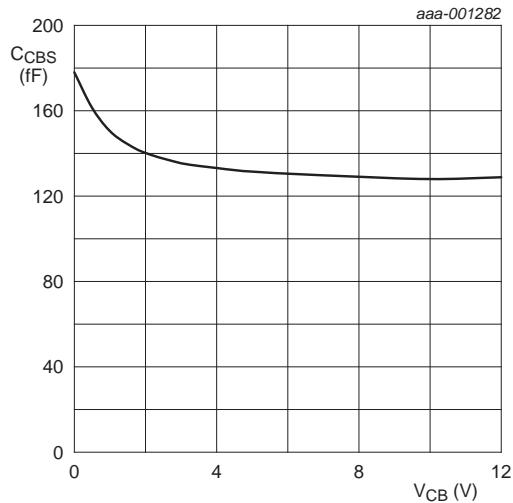
- $T_{amb} = 25^{\circ}\text{C}$ .
- (1)  $I_B = 50 \mu\text{A}$
  - (2)  $I_B = 100 \mu\text{A}$
  - (3)  $I_B = 150 \mu\text{A}$
  - (4)  $I_B = 200 \mu\text{A}$
  - (5)  $I_B = 250 \mu\text{A}$
  - (6)  $I_B = 300 \mu\text{A}$

**Fig 3.** Collector current as a function of collector-emitter voltage; typical values



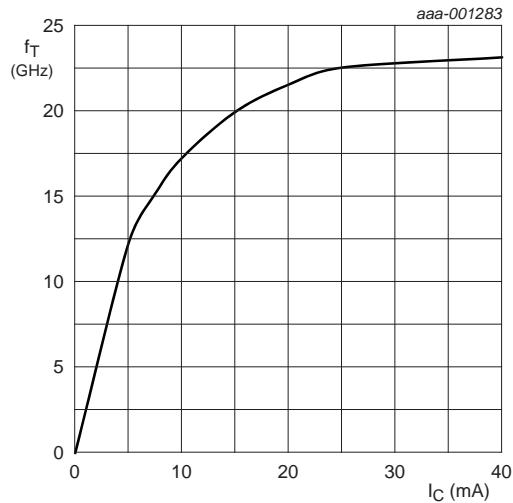
$V_{CE} = 2 \text{ V}; T_{amb} = 25^{\circ}\text{C}$ .

**Fig 4.** DC current gain as a function of collector current; typical values



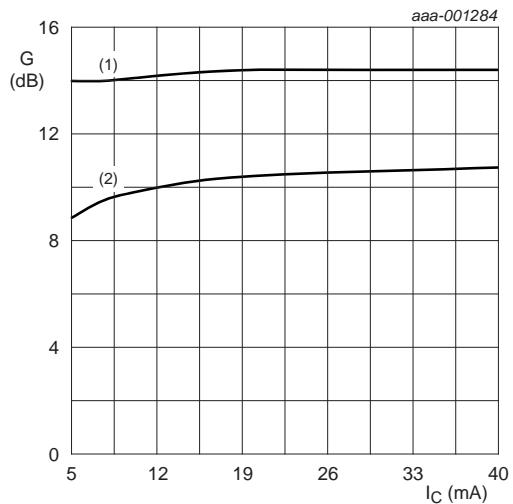
$f = 1$  MHz,  $T_{amb} = 25$  °C.

**Fig 5. Collector-base capacitance as a function of collector-base voltage; typical values**



$V_{CE} = 3.5$  V;  $f = 2$  GHz;  $T_{amb} = 25$  °C.

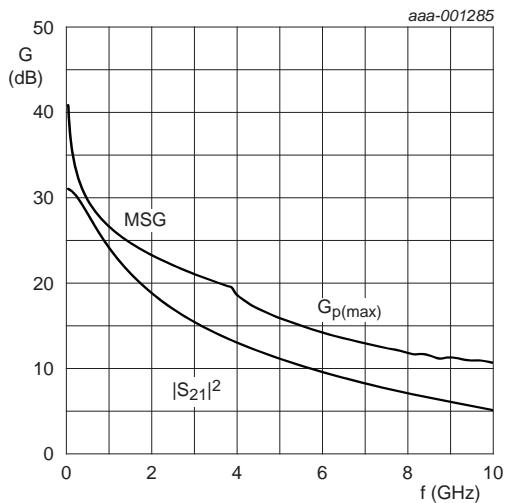
**Fig 6. Transition frequency as a function of collector current; typical values**



$V_{CE} = 3.5$  V;  $T_{amb} = 25$  °C.

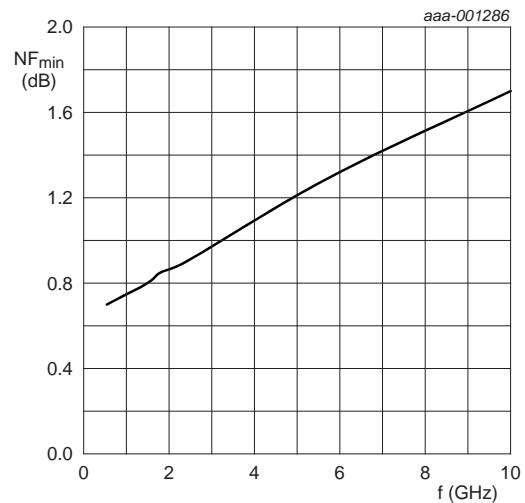
- (1)  $f = 5.8$  GHz
- (2)  $f = 10.0$  GHz

**Fig 7. Gain as a function of collector current; typical value**



$V_{CE} = 3.5$  V;  $I_C = 15$  mA;  $T_{amb} = 25$  °C.

**Fig 8. Gain as a function of frequency; typical values**



$V_{CE} = 3.5$  V;  $I_C = 15$  mA;  $T_{amb} = 25$  °C.

**Fig 9. Minimum noise figure as a function of frequency; typical values**

## 9. Package outline

Plastic surface-mounted flat pack package; reverse pinning; 4 leads

SOT343F

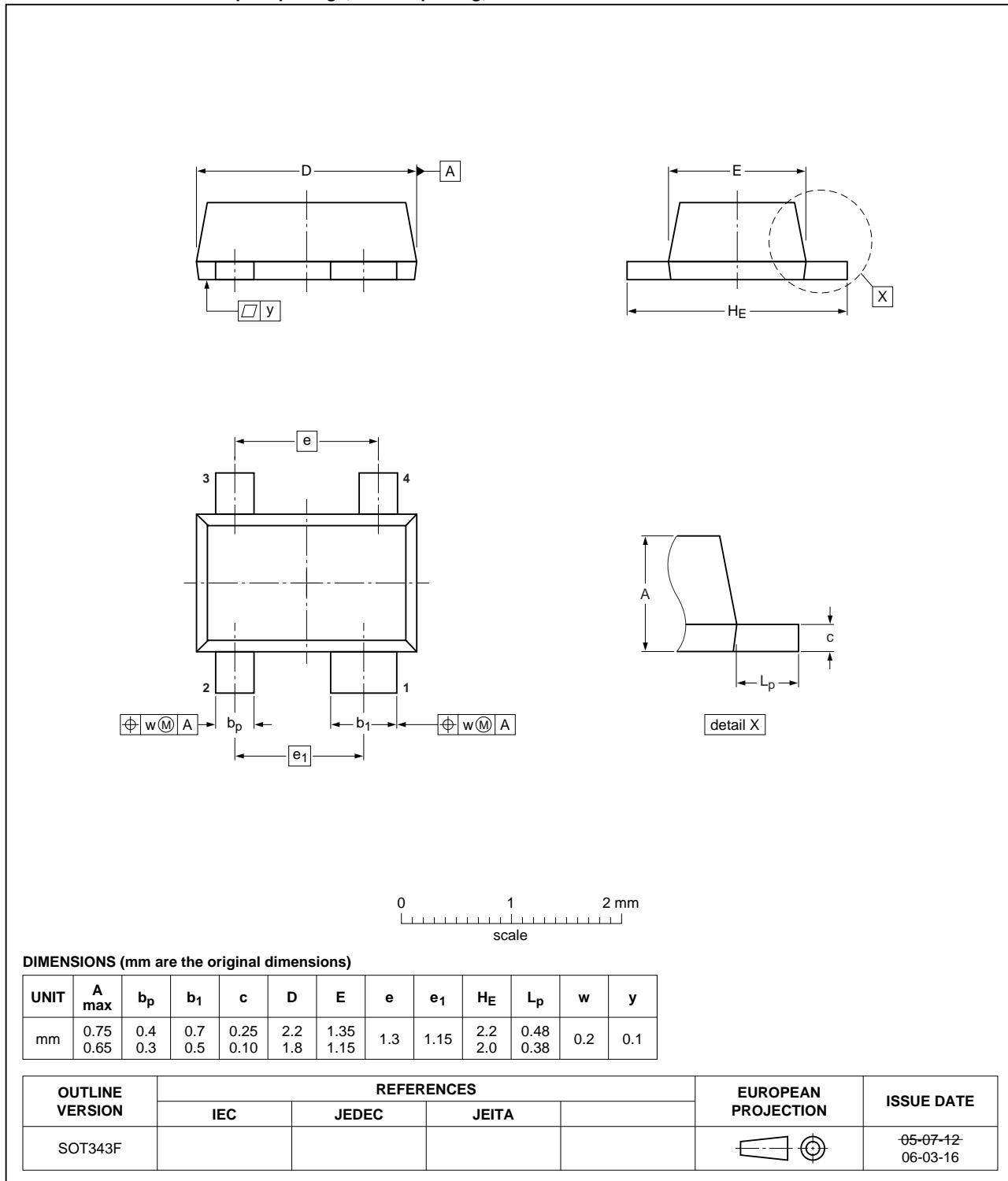


Fig 10. Package outline SOT343F

## 10. Abbreviations

**Table 8. Abbreviations**

Acronym	Description
DC	Direct Current
DRO	Dielectric Resonator Oscillator
Ku	Kurtz under
LNA	Low Noise Amplifier
LNB	Low Noise Block
NPN	Negative-Positive-Negative
RF	Radio Frequency

## 11. Revision history

**Table 9. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU668F v.3	20120124	Product data sheet	-	BFU668F v.2
Modifications:			<ul style="list-style-type: none"> <li>• <a href="#">Table 1 on page 2</a>: maximum value for <math>h_{FE}</math> has been changed.</li> <li>• <a href="#">Table 7 on page 5</a>: maximum value for <math>h_{FE}</math> has been changed.</li> </ul>	
BFU668F v.2	20120120	Product data sheet	-	BFU668F v.1
BFU668F v.1	20111108	Product data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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## 14. Contents

<b>1</b>	<b>Product profile</b>	<b>1</b>
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
1.4	Quick reference data	2
<b>2</b>	<b>Pinning information</b>	<b>2</b>
<b>3</b>	<b>Ordering information</b>	<b>3</b>
<b>4</b>	<b>Marking</b>	<b>3</b>
<b>5</b>	<b>Limiting values</b>	<b>3</b>
<b>6</b>	<b>Thermal characteristics</b>	<b>3</b>
<b>7</b>	<b>Characteristics</b>	<b>5</b>
<b>8</b>	<b>Application information</b>	<b>6</b>
8.1	BFU668F Ku-band Dielectric Resonator Oscillator (DRO)	6
8.2	Graphs	7
<b>9</b>	<b>Package outline</b>	<b>10</b>
<b>10</b>	<b>Abbreviations</b>	<b>11</b>
<b>11</b>	<b>Revision history</b>	<b>11</b>
<b>12</b>	<b>Legal information</b>	<b>12</b>
12.1	Data sheet status	12
12.2	Definitions	12
12.3	Disclaimers	12
12.4	Trademarks	13
<b>13</b>	<b>Contact information</b>	<b>13</b>
<b>14</b>	<b>Contents</b>	<b>14</b>

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